International Rectifier

POWER MOSFET THRU-HOLE (TO-257AA)

Product Summary

Part Number	RDS(on)	ΙD	Eyelets	
IRFY430C	1.5 Ω	4.5A	Ceramic	
IRFY430CM	1.5 Ω	4.5A	Ceramic	

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

IRFY430C, IRFY430CM 500V, N-CHANNEL HEXFET® MOSFET TECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Ceramic Eyelets
- Ideally Suited For Space Level Applications

Absolute Maximum Ratings

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	4.5	
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	2.8	Α
IDM	Pulsed Drain Current ①	18	
P _D @ T _C = 25°C	Max. Power Dissipation	75	W
	Linear Derating Factor	0.6	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy 2	280	mJ
IAR	Avalanche Current ①	4.5	Α
EAR	Repetitive Avalanche Energy ①	7.5	mJ
dv/dt	Peak Diode Recovery dv/dt 3	3.5	V/ns
TJ	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
	Lead Temperature	300(0.063in./1.6mm from case for 10 sec)	
	Weight	4.3 (Typical)	g

For footnotes refer to the last page

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

					P	
	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	500	_	_	V	VGS = 0V, ID = 1.0mA
ΔBV _{DSS} /ΔT _J	Temperature Coefficient of Breakdown Voltage	_	0.78	_	V/°C	Reference to 25°C, I _D = 1.0mA
RDS(on)	Static Drain-to-Source On-State Resistance	_	_	1.5	Ω	VGS = 10V, ID = 2.8A (4)
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	V _{DS} = V _{GS} , I _D = 250μA
9fs	Forward Transconductance	1.5	_	_	S	V _{DS} = 15V, I _{DS} = 2.8A ④
IDSS	Zero Gate Voltage Drain Current		_	25		VDS= 400V ,VGS=0V
		_	_	250	μΑ	V _{DS} = 400V,
						$V_{GS} = 0V, T_{J} = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_	_	100	nA	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA na	VGS = -20V
Qg	Total Gate Charge	_	_	29.5		VGS =10V, ID = 4.5A
Qgs	Gate-to-Source Charge	_	_	4.6	nC	V _{DS} = 250V
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	_	19.7		
^t d(on)	Turn-On Delay Time	_	_	35		$V_{DD} = 250V, I_D = 4.5A,$
tr	Rise Time	_	_	30	ns	$V_{GS} = 10V$, $R_{G} = 7.5\Omega$,
^t d(off)	Turn-Off Delay Time		_	55	ns	
tf	Fall Time	_	_	30		
Ls+LD	Total Inductance		6.8	_	nH	Measured from drain lead (6mm/0.25in. from
						package) to source lead (6mm/0.25in. from
						package)
C _{iss}	Input Capacitance	_	650	_		$V_{GS} = 0V, V_{DS} = 25V$
Coss	Output Capacitance		135	_	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	65	-		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Pulse Source Current (Body Diode) ① /SD Diode Forward Voltage		_	_	4.5	Α	
ISM			-	_	18		
VsD			_	_	1.4	V	$T_j = 25^{\circ}C$, $I_S = 4.5A$, $V_{GS} = 0V$ ④
t _{rr}			_	_	900	ns	Tj = 25°C, IF = 4.5A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		_	_	7.0	μC	V _{DD} ≤ 50V ④
ton Forward Turn-On Time Intrinsic turn-on time is negligible. Turn-on speed is substa					ed is substantially controlled by L _S + L _D .		

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	_	1.67		
RthCS	Case-to-sink	_	0.21	_	°C/W	
R _{th} JA	Junction-to-Ambient	_	_	80		Typical socket mount

Note: Corresponding Spice and Saber models are available on International Rectifier Website.

For footnotes refer to the last page

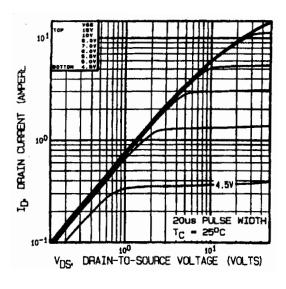


Fig 1. Typical Output Characteristics

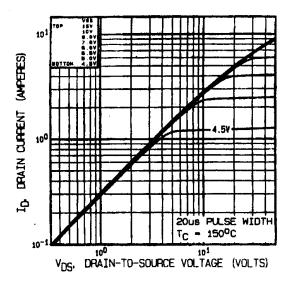


Fig 2. Typical Output Characteristics

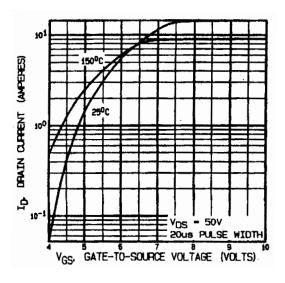


Fig 3. Typical Transfer Characteristics

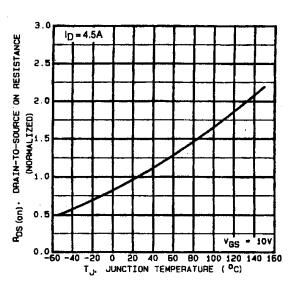


Fig 4. Normalized On-Resistance Vs. Temperature

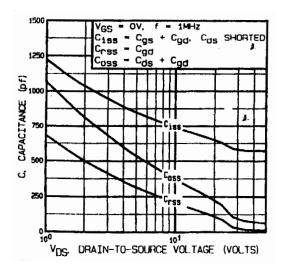
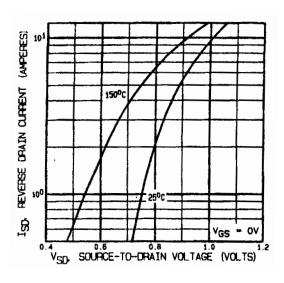


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage



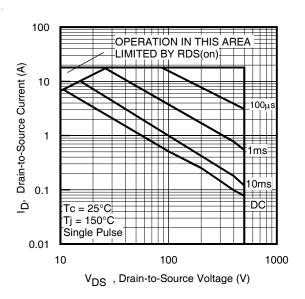


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

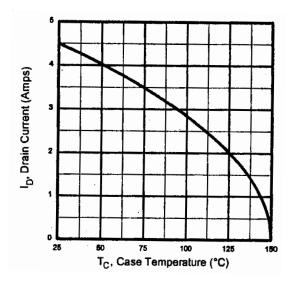


Fig 9. Maximum Drain Current Vs. Case Temperature

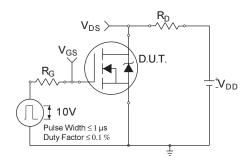


Fig 10a. Switching Time Test Circuit

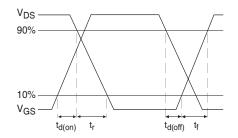


Fig 10b. Switching Time Waveforms

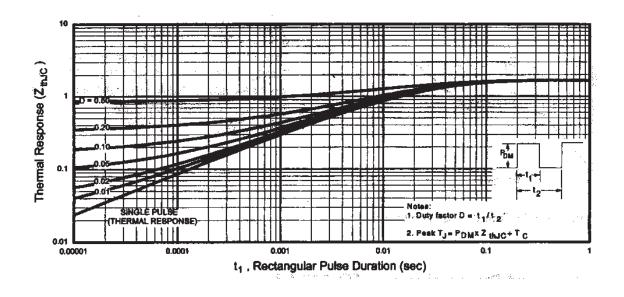


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

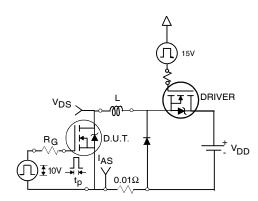


Fig 12a. Unclamped Inductive Test Circuit

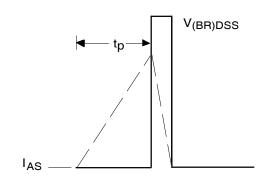


Fig 12b. Unclamped Inductive Waveforms

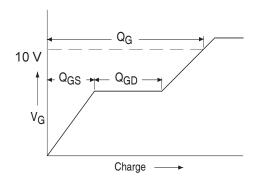


Fig 13a. Basic Gate Charge Waveform

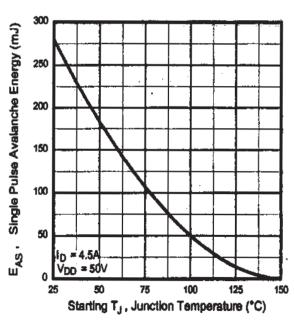


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

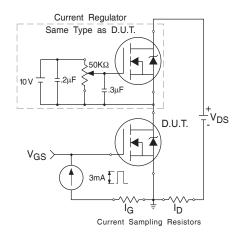
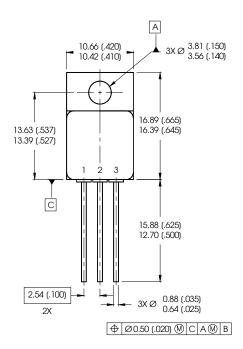


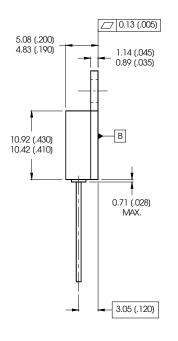
Fig 13b. Gate Charge Test Circuit

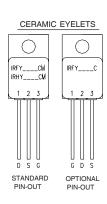
Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$ V_{DD} = 50V, starting T_J = 25°C, L= 28mH Peak I_L = 4.5A, V_{GS} = 10V
- $\label{eq:local_state} \begin{tabular}{ll} \begin{tabular}{ll}$
- 4 Pulse width \leq 300 μ s; Duty Cycle \leq 2%

Case Outline and Dimensions — TO-257AA







NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-257AA

PIN ASSIGNMENTS

1 = DRAIN

2 = SOURCE

3 = GATE

International Rectifier

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